

ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	Value	Unit
Drain-source (GND) voltage ⁽¹⁾	V _{DSS}	650	V
Drain-Gate voltage (R _{GS} =1MΩ)	V _{DGR}	650	V
Gate-source (GND) voltage	V _{GS}	±30	V
Drain current pulsed ⁽²⁾	I _{DM}	28.0	A _{DC}
Single pulsed avalanche energy ⁽³⁾	E _{AS}	570	mJ
Avalanche current ⁽⁴⁾	I _{AS}	20	A
Continuous drain current (T _C =25°C)	I _D	7.0	A _{DC}
Continuous drain current (T _C =100°C)	I _D	5.6	A _{DC}
Supply voltage	V _{CC}	30	V
Analog input voltage range	V _{FB}	-0.3 to V _{SD}	V
Total power dissipation	P _D (wt H/S)	135	W
	Derating	1.1	W/°C
Operating temperature	T _{OPR}	-25 to +85	°C
Storage temperature	T _{STG}	-55 to +150	°C

NOTES:

1. T_j=25°C to 150°C
2. Repetitive rating: Pulse width limited by maximum junction temperature
3. L=24mH, starting T_j=25°C
4. L=13uH, starting T_j=25°C

ELECTRICAL CHARACTERISTICS (SFET part)

(Ta=25°C unless otherwise specified)

Characteristic	Symbol	Test condition	Min.	Typ.	Max.	Unit
Drain-source breakdown voltage	BV_{DSS}	$V_{GS}=0V, I_D=50\mu A$	650	–	–	V
Zero gate voltage drain current	I_{DSS}	$V_{DS}=\text{Max.}, \text{Rating}, V_{GS}=0V$	–	–	200	μA
		$V_{DS}=0.8\text{Max.}, \text{Rating}, V_{GS}=0V, T_C=125^\circ C$	–	–	500	μA
Static drain-source on resistance ^(note)	$R_{DS(ON)}$	$V_{GS}=10V, I_D=4.0A$	–	1.25	1.6	Ω
Forward transconductance ^(note)	gfs	$V_{DS}=15V, I_D=4.0A$	3.0	–	–	S
Input capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=25V, f=1\text{MHz}$	–	1600	–	pF
Output capacitance	C_{oss}		–	310	–	
Reverse transfer capacitance	C_{rss}		–	120	–	
Turn on delay time	td(on)	$V_{DD}=0.5BV_{DSS}, I_D=7.0A$ (MOSFET switching time are essentially independent of operating temperature)	–	25	–	nS
Rise time	tr		–	55	–	
Turn off delay time	td(off)		–	80	–	
Fall time	tf		–	50	–	
Total gate charge (gate-source+gate-drain)	Qg	$V_{GS}=10V, I_D=7.0A, V_{DS}=0.5BV_{DSS}$ (MOSFET switching time are essentially independent of operating temperature)	–	–	72	nC
Gate-source charge	Qgs		–	9.3	–	
Gate-drain (Miller) charge	Qgd		–	29.3	–	

NOTE: Pulse test: Pulse width $\leq 300\mu S$, duty cycle $\leq 2\%$

ELECTRICAL CHARACTERISTICS (Control part)

(Ta=25°C unless otherwise specified)

Characteristic	Symbol	Test condition	Min.	Typ.	Max.	Unit
SENSE FET SECTION						
Drain to PKG Breakdown voltage	BVpkg	60Hz AC, Ta=25°C	3500	–	–	V
Drain to Source Breakdown voltage	BVdss	Vdrain=650V, Ta=25°C	650	–	–	V
Drain to Source Leakage current	Idss	Vdrain=650V, Ta=25°C	–	–	200	μA
OSCILLATOR SECTION						
Initial Frequency	F _{OSC}	–	18	20	22	KHz
Voltage Stability	F _{STABLE}	12≤V _{CC} ≤23V	0	1	3	%
Temperature Stability ^{note 2}	ΔF _{OSC}	-25°C≤Ta≤85°C	0	±5	±10	%
Maximum Duty Cycle	D _{MAX}	–	92	95	98	%
Minimum Duty Cycle	D _{MIN}	–	–	–	0	%
UVLO SECTION						
Start Threshold Voltage	V _{START}	V _{FB} =GND	14	15	16	V
Stop Threshold Voltage	V _{STOP}	V _{FB} =GND	8	9	10	V
FEEDBACK SECTION						
Feedback Source Current	I _{FB}	V _{FB} =GND	0.7	0.9	1.1	mA
Shutdown Feedback Voltage	V _{SD}	V _{fb} ≥6.9V	6.9	7.5	8.1	V
Shutdown Delay Current	I _{DELAY}	V _{FB} =5V	4	5	6	μA
PROTECTION SECTION						
Over Current Protection	V _{OVP}	V _{sync} ≥11V	11	12	13	V
Over Current Latch Voltage ^{note 2}	V _{OCL}	–	0.9	1.0	1.1	V
Thermal shutdown Temp.	TSD	–	140	160	–	°C
SYNC SECTION						
Normal Sync High Threshold Voltage	V _{NSH}	V _{CC} =16V, V _{fb} =5V	4.0	4.6	5.2	V
Normal Sync Low Threshold Voltage	V _{NSL}	V _{CC} =16V, V _{fb} =5V	2.3	2.6	2.9	V
Burst High Threshold Voltage	V _{BSH}	V _{CC} =10.5V, V _{fb} =0V	3.2	3.6	4.0	V
Burst Low Threshold Voltage	V _{BSL}	V _{CC} =10.5V, V _{fb} =0V	1.1	1.3	1.5	V

ELECTRICAL CHARACTERISTICS (Continued)

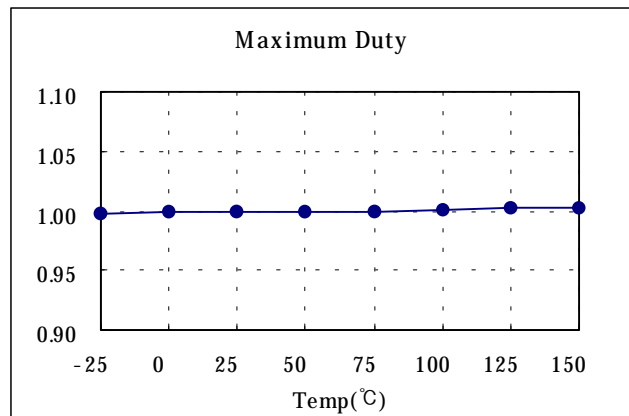
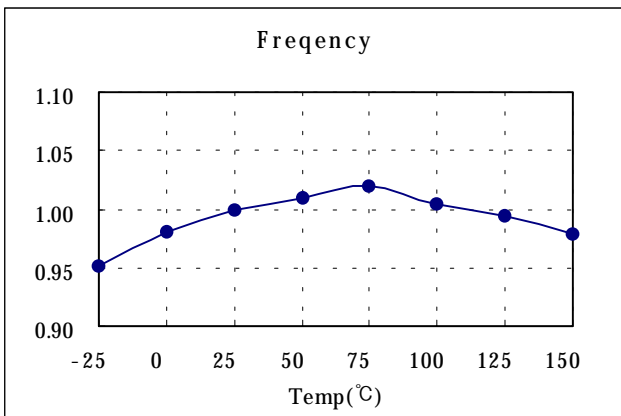
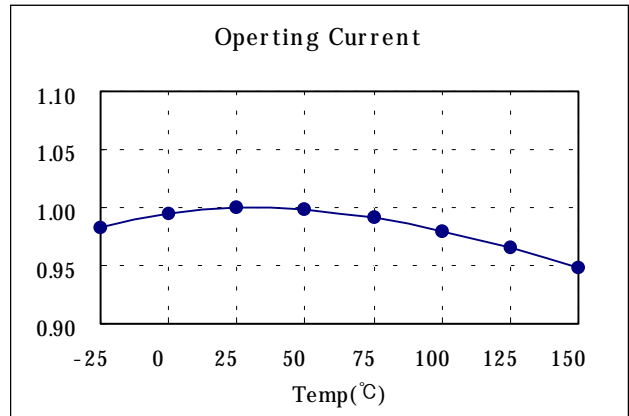
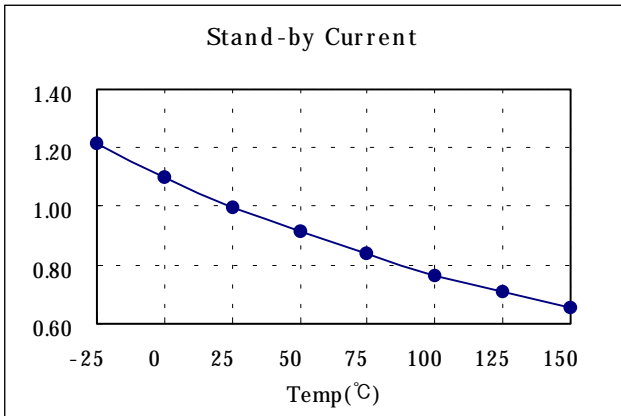
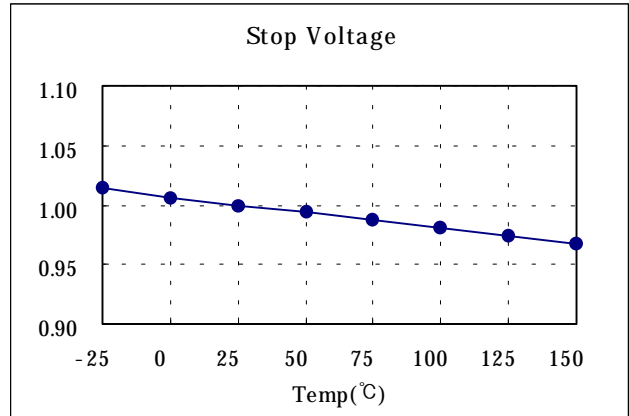
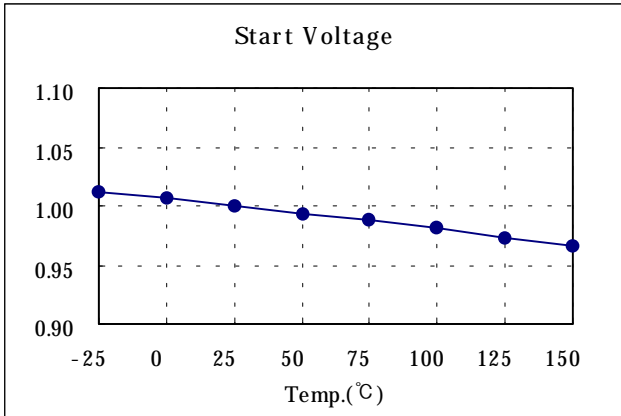
(Ta=25°C unless otherwise specified)

Characteristic	Symbol	Test condition	Min.	Typ.	Max.	Unit
BURST MODE SECTION						
Burst mode Low Threshold Voltage	V _{BURL}	Vfb=0V	10.4	11.0	11.6	V
Burst mode High Threshold Voltage	V _{BURH}	Vfb=0V	11.4	12.0	12.6	V
Burst mode Enable Feedback voltage	V _{BEN}	V _{CC} =10.5V	0.7	1.0	1.3	V
Burst mode Peak Current Limit	I _{BU_PK}	V _{CC} =10.5V	0.65	0.85	1.0	V
PRIMARY SIDE REGULATION SECTION						
Primary Regulation Threshold Voltage	V _{PR}	I _{fb} =700μA, Vfb=4V	32.0	32.5	33.0	V
Primary Regulation Transconductance	G _{PR}	–	2.0	2.6	–	mA/V
CURRENT LIMIT (SELF-PROTECTION) SECTION						
Peak Current Limit ^{note 3}	I _{PK}	–	4.4	5.0	5.6	A
START UP CURRENT						
Start up Current	I _{START}	Vfb=GND, V _{CC} =14V	–	0.1	0.2	mA
Operatig Supply Current ^{noet 1}	I _{OP}	Vfb=GND, V _{CC} =16V	–	10	18	mA
	I _{OP(MIN)}	Vfb=GND, V _{CC} =12V				
	I _{OP(MAX)}	Vfb=GND, V _{CC} =28V				

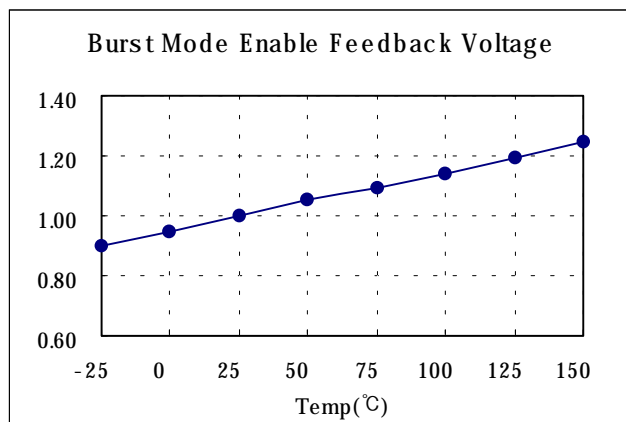
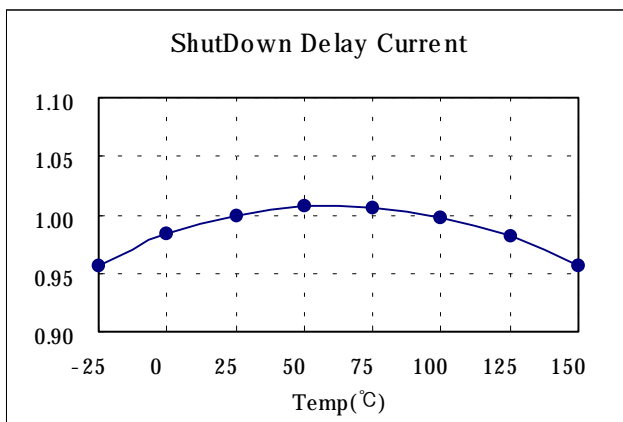
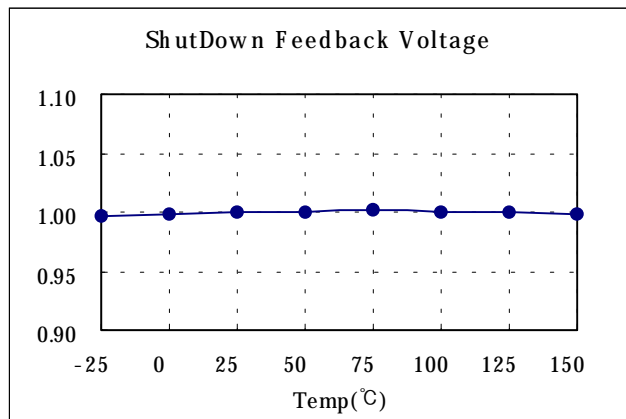
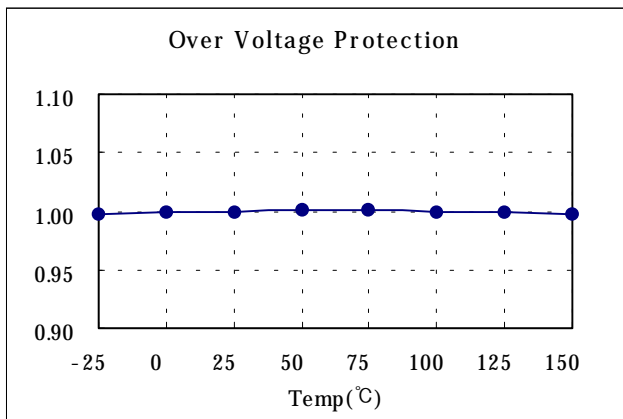
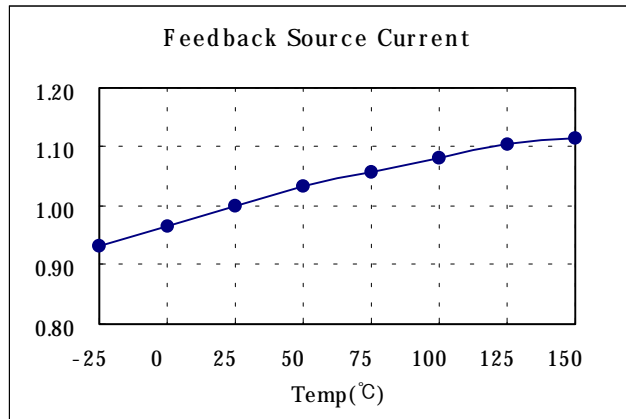
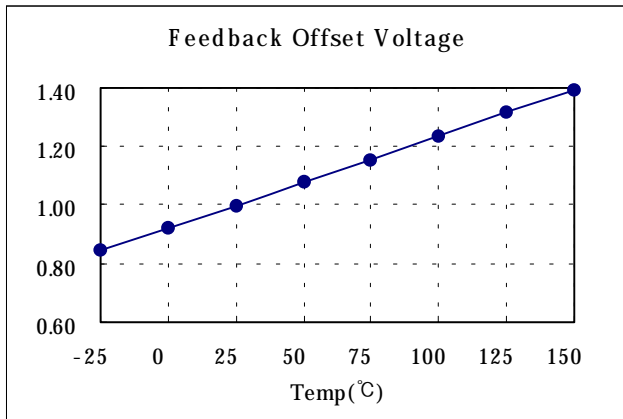
NOTE:

1. These parameters, although guaranteed, are not 100% tested in production
2. These parameters, although guaranteed, are tested in EDS (wafer test) process
3. These parameters indicate inductor current

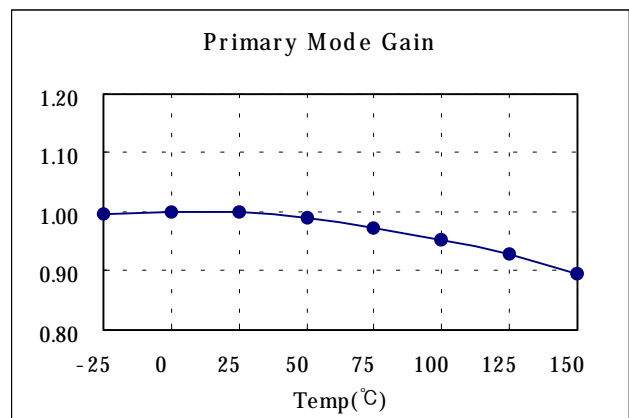
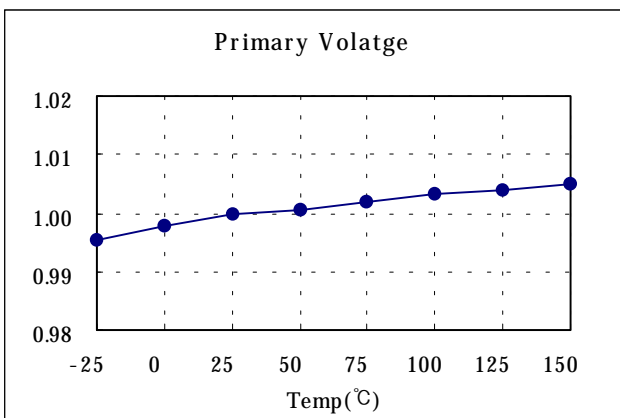
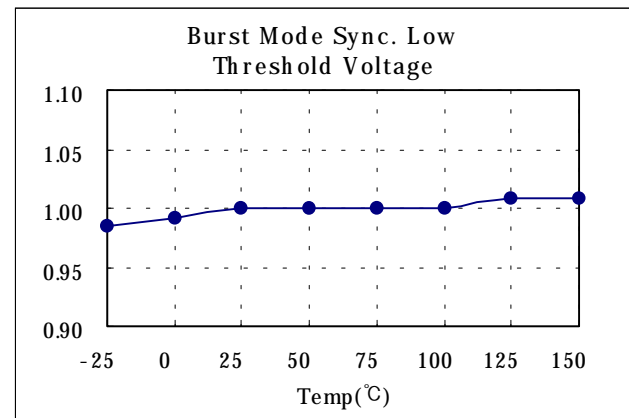
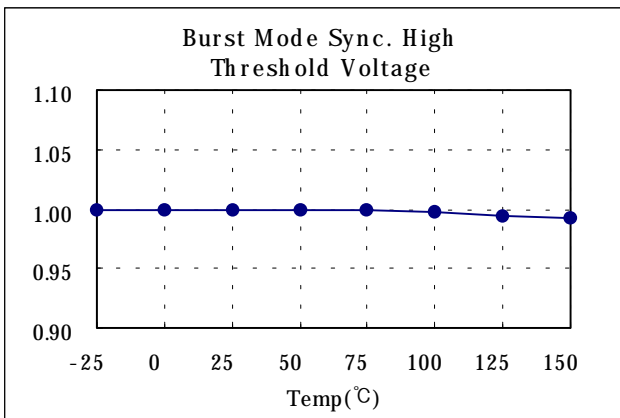
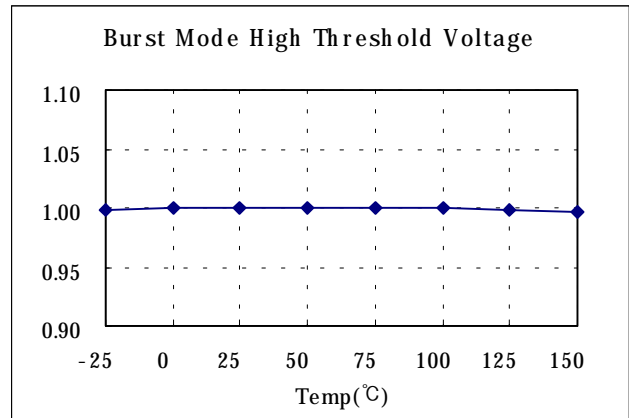
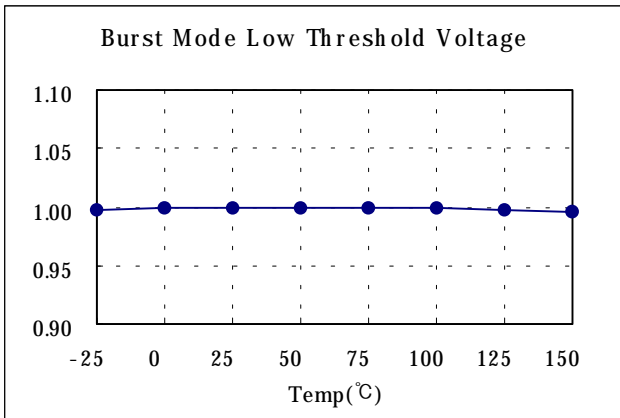
TYPICAL PERFORMANCE CHARACTERISTICS



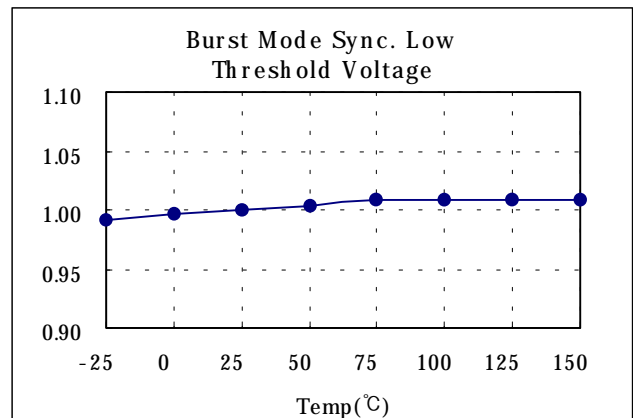
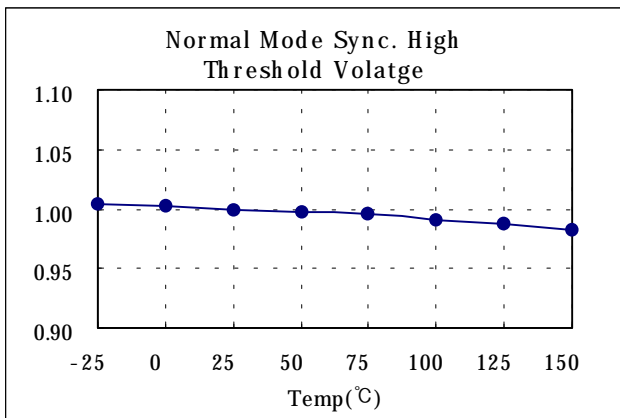
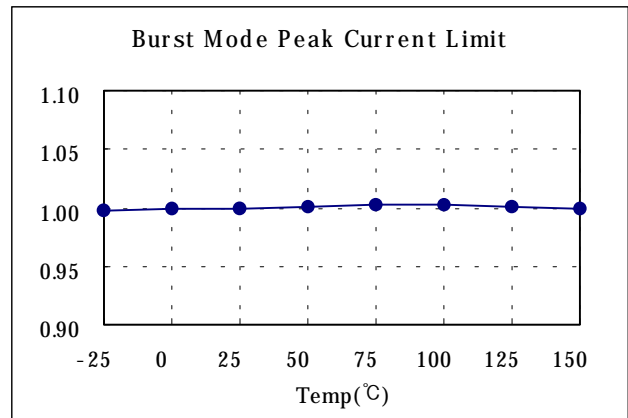
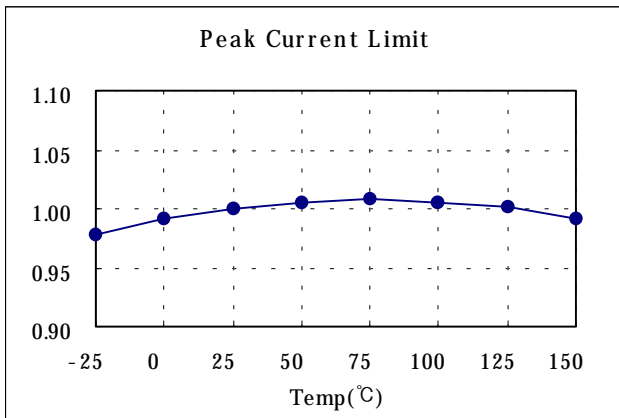
TYPICAL PERFORMANCE CHARACTERISTICS (Continued)



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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.